MSKSEMI















ESD

TVS

TSS

MOV

GDT

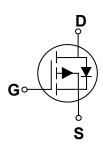
PLED

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SOT-23-3L



Features

- -20V,-3A, RDS(ON) = $60m\Omega@VGS = -4.5V$
- Improved dv/dt capability
- Fast switching
- Green Device Available

Applications

- Notebook
- Load Switch
- Battery Protection
- Hand-held Instruments

BVDSS	RDSON	ID
-20V	$60 \mathrm{m}\Omega$	-3A

Absolute Maximum Ratings Tc=25 unless otherwise noted

Symbol	Parameter	Rating	Units
V _D s	Drain-Source Voltage	-20	V
Vgs	Gate-Source Voltage	±12	V
	Drain Current – Continuous (T _C =250)	-3.0	А
ID .	Drain Current – Continuous (T _C =1000)	-2.0	А
I _{DM}	Drain Current – Pulsed ¹	-12	А
D	Power Dissipation (T _C =250)	1.56	W
P _D	Power Dissipation – Derate above 250	0.012	W/ C
T _{STG}	Storage Temperature Range	-55 to 150	С
TJ	Operating Junction Temperature Range	-55 to 150	С

Thermal Characteristics

Symbol	Parameter	Тур.	Max.	Unit
Reja	Thermal Resistance Junction to ambient		80	c/ W

Off Characteristics

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
BV _{DSS}	Drain-Source Breakdown Voltage	rain-Source Breakdown Voltage V _{GS} =0V , I _D =-250uA				٧
△ BV _{DSS} / △ T _J	BV _{DSS} Temperature Coefficient	Reference to 250 , I _D =-1mA		-0.01		V/ C
	Dunin Course Looks as Courset	V _{DS} =-20V , V _{GS} =0V , T _J =250			-1	uA
I _{DSS} Drain-Source Leakage Current		V _{DS} =-16V , V _{GS} =0V , T _J =125C			-10	uA
Igss	Gate-Source Leakage Current	V _{GS} = ±12V , V _{DS} =0V			±10	uA

On Characteristics

R _{DS(ON)}	R _{DS(ON)} Static Drain-Source On-Resistance	V _{GS} =-4.5V , I _D =-3A		60	80	mΩ	
Static Diani-Source On-Resistance		V _{GS} =-2.5V , I _D =-2A		80	120	1115-2	
V _{GS(th)}	Gate Threshold Voltage	\/ \/ L 050\	-0.3	-0.65	-1.1	V	
△ V _{GS(th)}	V _{GS(th)} Temperature Coefficient	V _{GS} =V _{DS} , I _D =-250uA		3		mV/ C	
gfs	Forward Transconductance	V _{DS} =-10V , I _S =-1A		2.2		S	

Dynamic and switching Characteristics

Qg	Total Gate Charge ^{2, 3}		 4.8	
Q _{gs}	Gate-Source Charge ^{2, 3}	V _{DS} =-10V , V _{GS} =-4.5V , I _D =-3A	 0.5	 nC
Q_{gd}	Gate-Drain Charge ^{2, 3}		 1.9	
T _{d(on)}	Turn-On Delay Time ^{2, 3}		 3.5	
Tr	Rise Time ^{2,3}	V_{DD} =-10V , V_{GS} =-4.5V , R_{G} =25 Ω	 12.6	 0
T _{d(off)}	Turn-Off Delay Time ^{2,3}	I _D =-1A	 32.6	 nS
T _f	Fall Time ^{2,3}		 8.4	
C _{iss}	Input Capacitance		 550	
Coss	Output Capacitance	V _{DS} =-10V , V _{GS} =0V , F=1MHz	 65	 pF
Crss	Reverse Transfer Capacitance		 55	

Drain-Source Diode Characteristics and Maximum Ratings

Symbol	Parameter	Parameter Conditions		Тур.	Max.	Unit
ls	Continuous Source Current	V V 0V 5 0			-3.0	Α
lsм	Pulsed Source Current	V _G =V _D =0V , Force Current			-13	Α
Vsp	Diode Forward Voltage	V _{GS} =0V , I _S =-1A , T _J =250			-1.2	V

Note

- 1. Repetitive Rating : Pulsed width limited by maximum junction temperature.
- 2. The data tested by pulsed , pulse width $\leq 300 \, \text{us}$, duty cycle $\leq 2\%$.
- 3. Essentially independent of operating temperature.

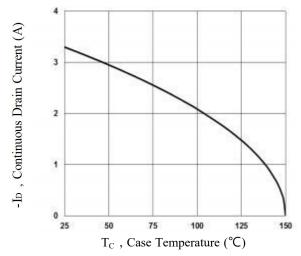


Fig.1 Continuous Drain Current vs. T_c

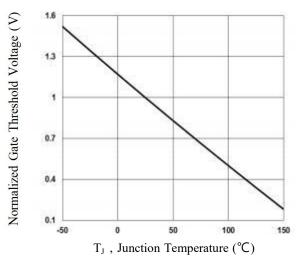


Fig.3 Normalized V_{th} vs. T_J

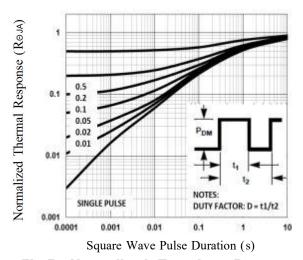


Fig.5 Normalized Transient Response

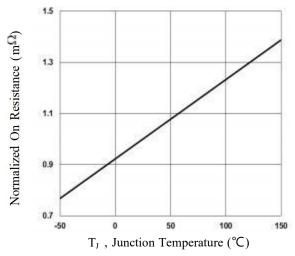


Fig. 2 Normalized RDSON vs. T_J

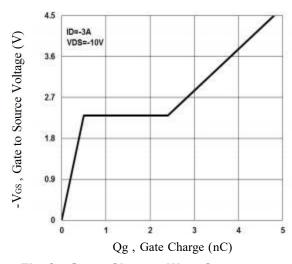


Fig.4 Gate Charge Waveform

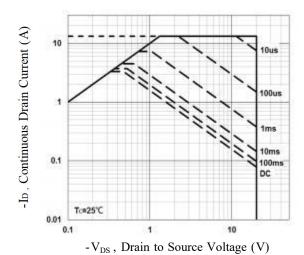
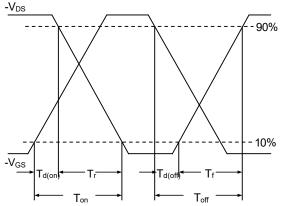


Fig.6 Maximum Safe Operation Area







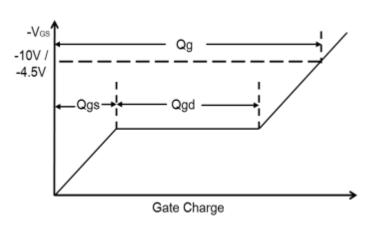
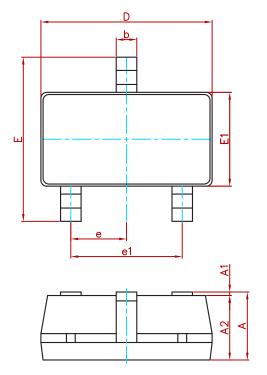
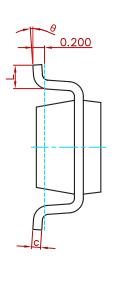


Fig. 8 Gate Charge Waveform

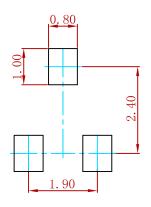
PACKAGE MECHANICAL DATA





Symbol	Dimensions In Millimeters		Dimension	s In Inches
Syllibol	Min.	Max.	Min.	Max.
Α	1.050	1.250	0.041	0.049
A1	0.000	0.100	0.000	0.004
A2	1.050	1.150	0.041	0.045
b	0.300	0.500	0.012	0.020
С	0.100	0.200	0.004	0.008
D	2.820	3.020	0.111	0.119
E1	1.500	1.700	0.059	0.067
E	2.650	2.950	0.104	0.116
е	0.950(BSC)		0.037((BSC)
e1	1.800	2.000	0.071	0.079
L	0.300	0.600	0.012	0.024
θ	0°	8°	0°	8°

Suggested Pad Layout



- 1.Controlling dimension:in millimeters.
- 2.General tolerance:± 0.05mm.3.The pad layout is for reference purposes only.

REEL SPECIFICATION

P/N	PKG	QTY
AO3413	SOT-23-3L	3000



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